

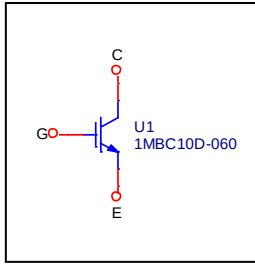
Device Modeling Report

COMPONENTS: Insulated Gate Bipolar Transistor (IGBT)
PART NUMBER: 1MBC10D-060
MANUFACTURER: FUJI ELECTRIC
* REMARK: Free-Wheeling Diode Special Model



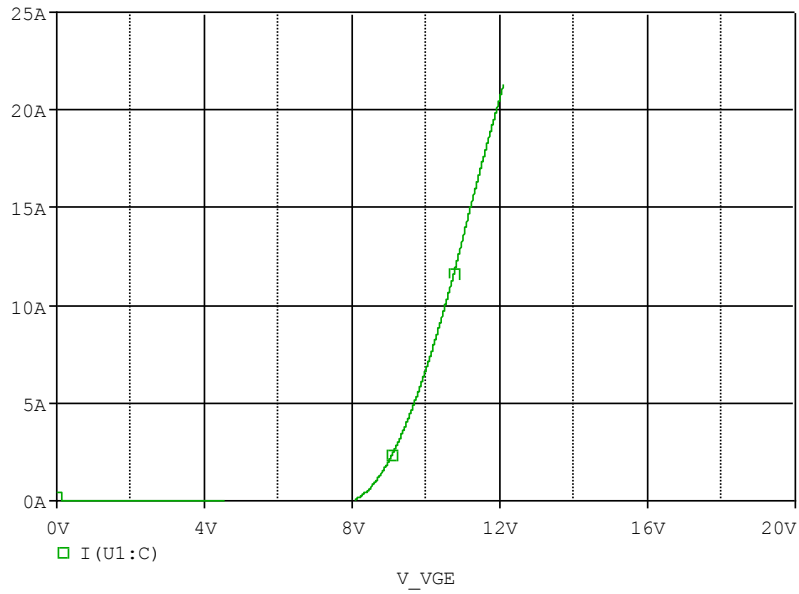
Bee Technologies Inc.

Circuit Configuration

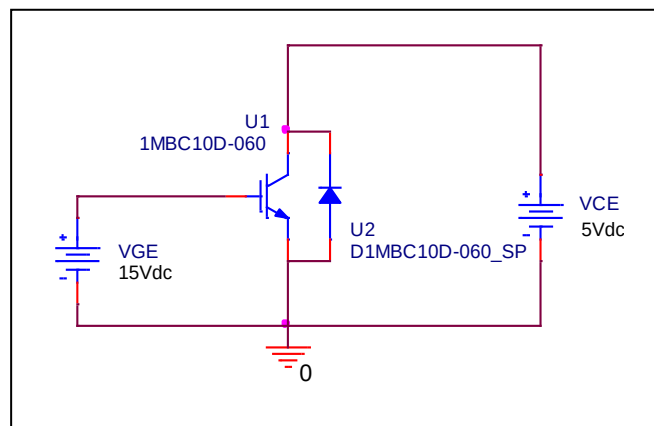


Transfer Characteristics

Circuit Simulation result

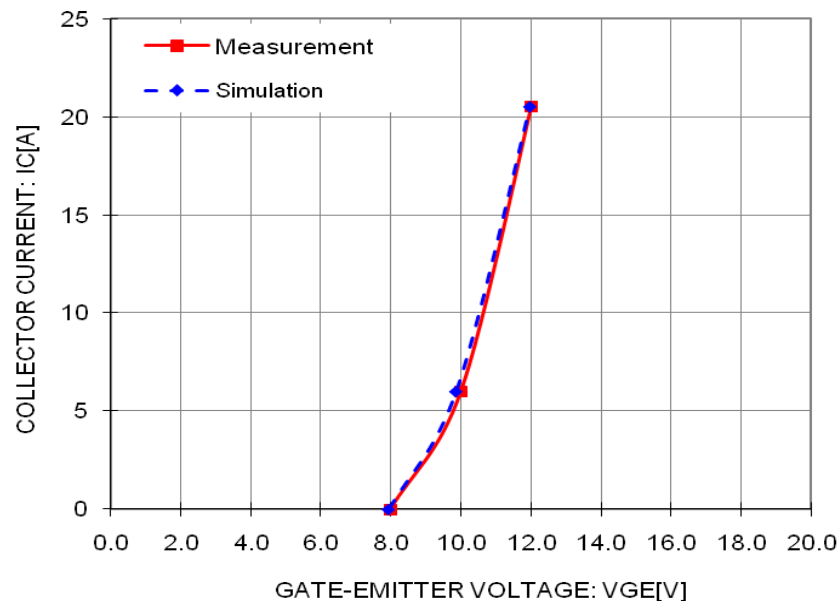


Evaluation circuit



Comparison Graph

Simulation result



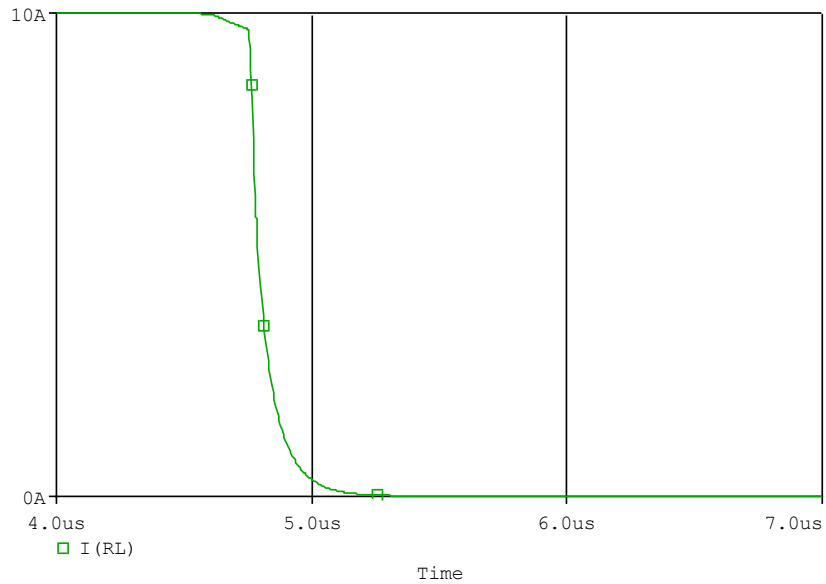
Comparison table

Test condition: $V_{CE} = 5$ (V)

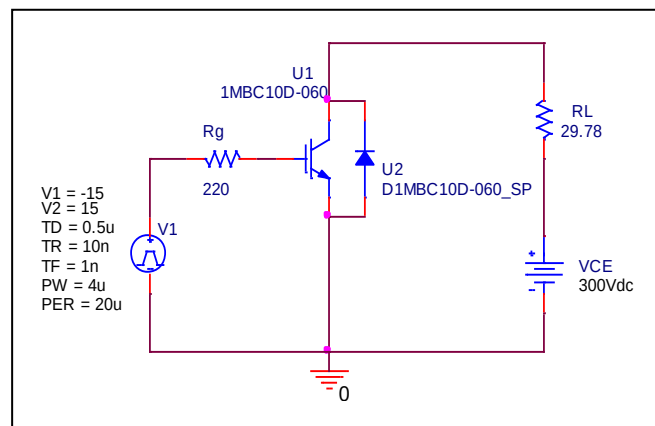
IC (A)	VGE (V)		%Error
	Measurement	Simulation	
0.000	8.000	8.017	0.21
6.000	10.000	9.870	-1.30
20.500	12.000	11.983	-0.14

Fall Time Characteristics

Circuit Simulation result



Evaluation circuit

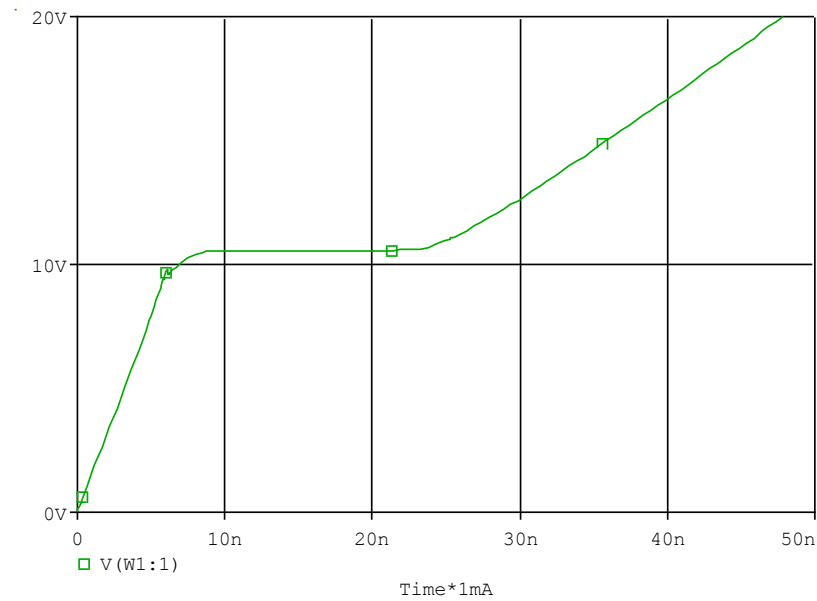


Test condition: $I_C=10$ (A), $V_{CC}=300$ (V)

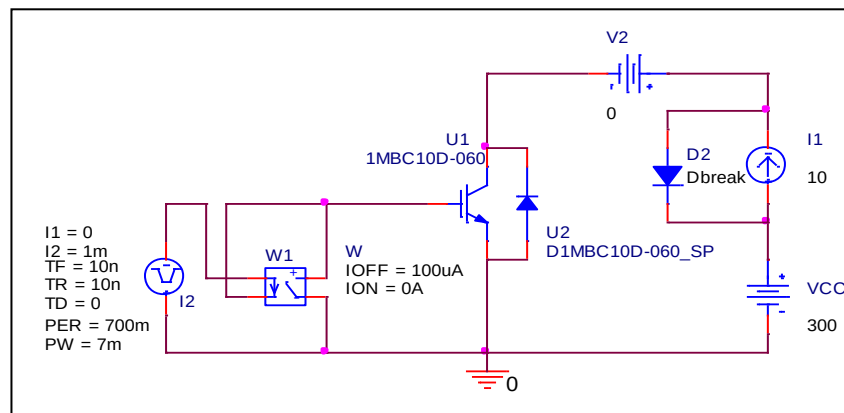
Parameter	Unit	Measurement	Simulation	%Error
tf	us	0.150	0.150	-0.29

Gate Charge Characteristics

Circuit Simulation result



Evaluation circuit

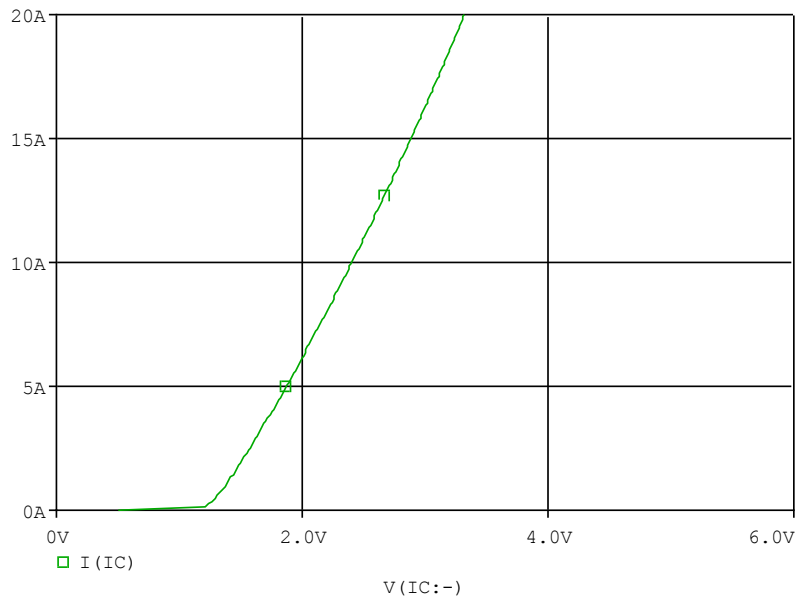


Test condition: $V_{CC}=300$ (V), $I_C=10$ (A), $V_{GE}=15$ (V)

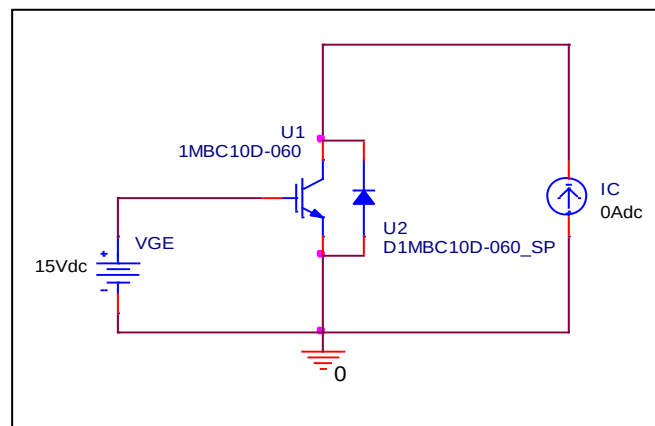
Parameter	Unit	Measurement	Simulation	%Error
Qge	nc	6.000	6.054	0.90
Qgc	nc	17.500	17.189	-1.78
Qg	nc	35.600	35.891	0.817

Saturation Characteristics

Circuit Simulation result

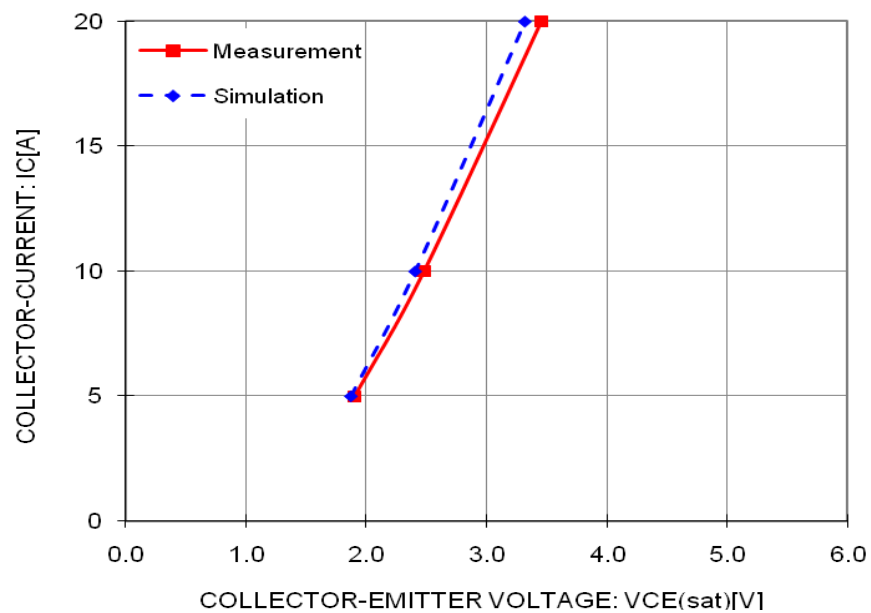


Evaluation circuit



Comparison Graph

Simulation result



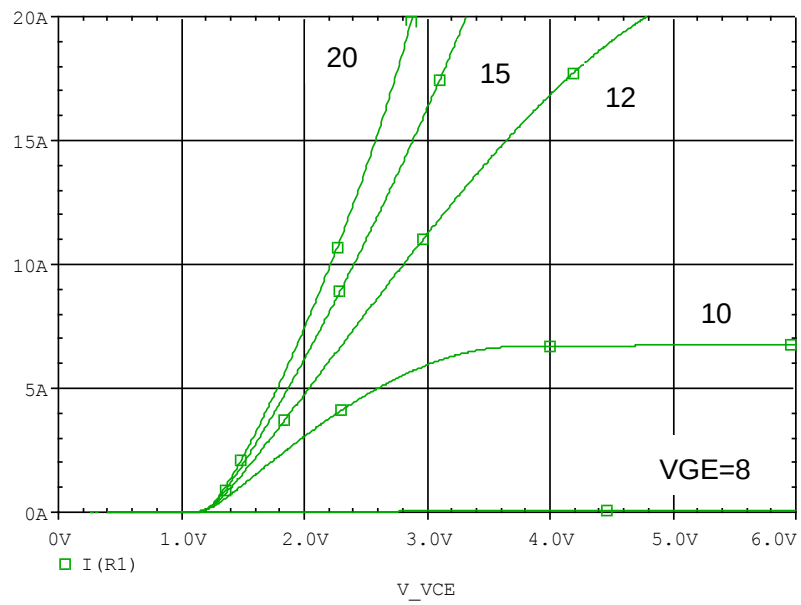
Comparison table

Test condition: $V_{GE} = 15$ (V)

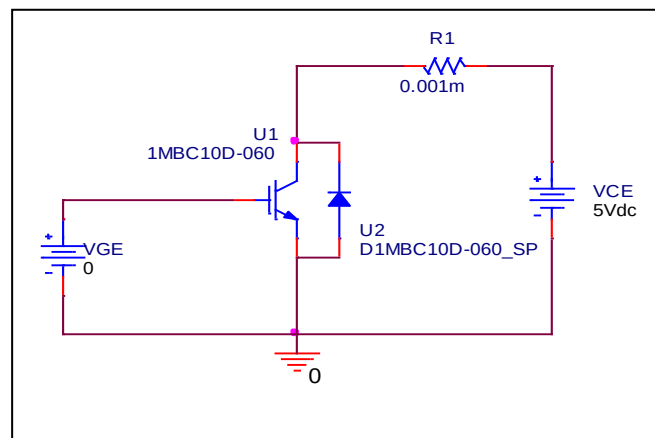
IC (A)	VCE (V)		%Error
	Measurement	Simulation	
5	1.900	1.869	-1.63
10	2.475	2.404	-2.87
20	3.450	3.319	-3.80

Output Characteristics

Circuit Simulation result

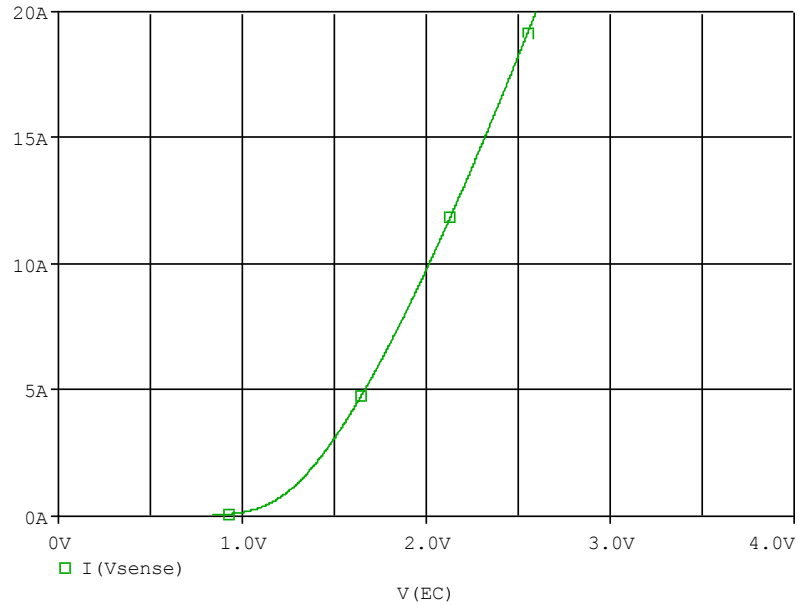


Evaluation circuit

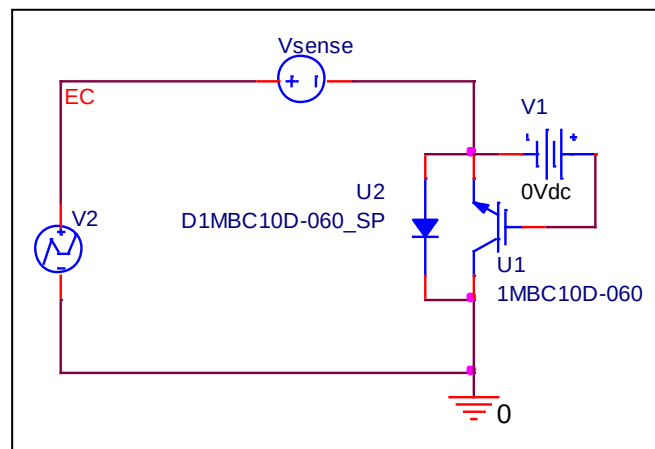


FWD Forward Current Characteristics

Circuit Simulation result

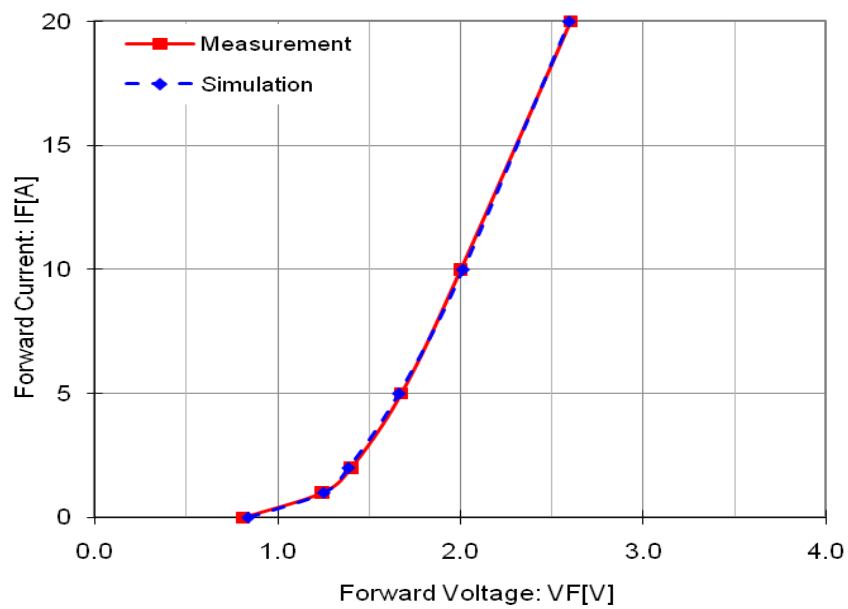


Evaluation circuit



Comparison Graph

Simulation result

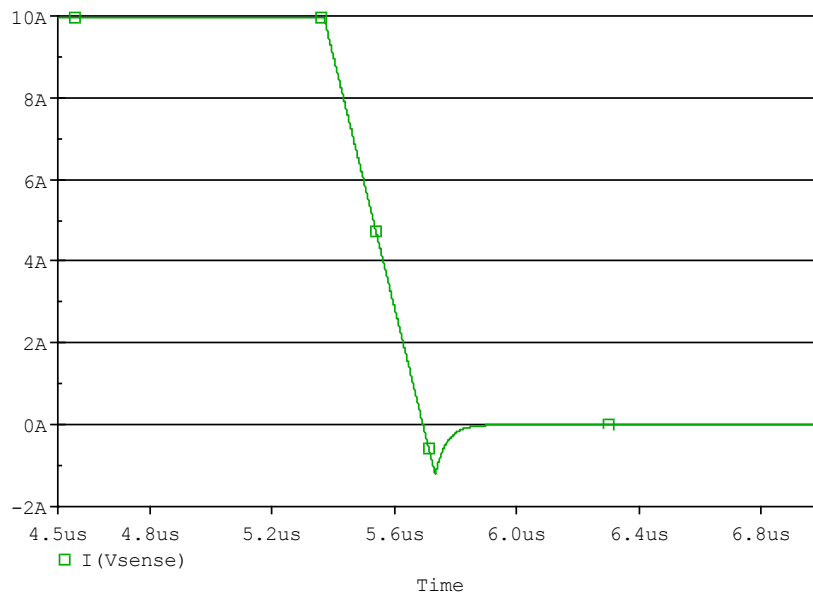


Comparison table

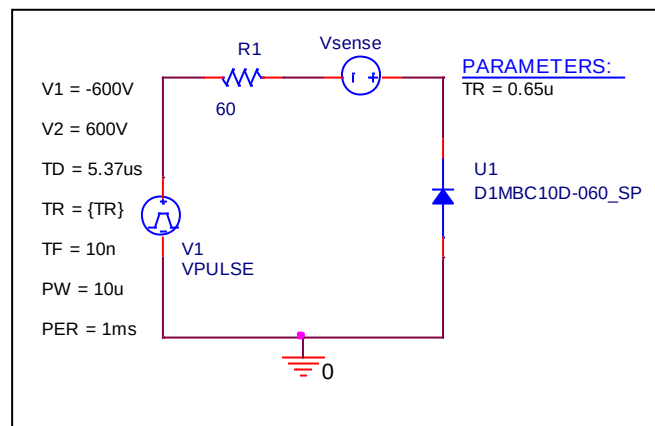
IF(A)	VF (V)		%Error
	Measurement	Simulation	
0	0.810	0.841	3.83
1	1.240	1.253	1.02
2	1.400	1.388	-0.84
5	1.675	1.665	-0.61
10	2.000	2.015	0.75
20	2.600	2.597	-0.11

Reverse Recovery Characteristics

Circuit Simulation result



Evaluation circuit



Test condition: $V_{CC}=600$ (V), $I_C=10$ (A), $-di/dt=30A/usec$.

Parameter	Unit	Measurement	Simulation	%Error
trr	nsec	125.000	124.657	-0.27
Irr	A	1.200	1.209	0.76